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<input type="text" value="AND"/>		<input type="text"/>	in All Fields
<input type="text" value="AND"/>		<input type="text"/>	in All Fields

» Note: If you use all three search boxes, the entries in the first two boxes take precedence over the entry in the third box.

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Enter keywords, phrases, or a Boolean expression

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```
(fmri or (functional <near/1> mri) or
(functional <near/1> magnetic resonance))
<paragraph> ((correlat* or compar* or
match*) <sentence> (time <near/3> curve)
<sentence> (model or reference or
predetermin*))
```

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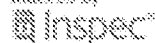
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